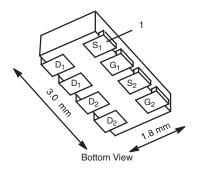


# SI5915BDC-T1-GE3-VB Datasheet Dual P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
	0.083 at V <sub>GS</sub> = - 4.5 V	- 4 <sup>9</sup>				
- 20	0.100 at V <sub>GS</sub> = - 2.5 V	- 4 <sup>9</sup>	6.2 nC			
	0.130 at V <sub>GS</sub> = - 1.8 V	- 3.8				

## DFN 3x2



#### **FEATURES**

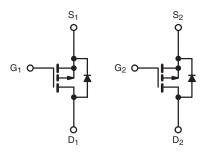
- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFETs
- 100 % R<sub>q</sub> Tested
- Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- · Load Switch for Portable Devices
- Battery Switch



P-Channel MOSFET

P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> T <sub>A</sub> = 25 °C, unless otherwise noted							
Parameter	Symbol	Limit	Unit				
Drain-Source Voltage	$V_{DS}$	- 20	V				
Gate-Source Voltage	V <sub>GS</sub>	± 8					
	T <sub>C</sub> = 25 °C		- 4 <sup>9</sup>				
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	$T_C = 70  ^{\circ}C$	I <sub>D</sub>	- 3.8				
Continuous Brain Current (1) = 130 C)	T <sub>A</sub> = 25 °C	υ -	- 3.1 <sup>b, c</sup>				
	T <sub>A</sub> = 70 °C		- 2.5 <sup>b, c</sup>	Α			
Pulsed Drain Current	I <sub>DM</sub>	- 10					
Source Drain Current Diode Current	$T_C = 25  ^{\circ}C$	I <sub>S</sub>	- 2.6				
Source Diain Current blode Current	$T_A = 25 ^{\circ}C$	'5	- 1.7 <sup>b, c</sup>				
	T <sub>C</sub> = 25 °C		3.1				
Maximum Power Dissipation	$T_C = 70  ^{\circ}C$	P <sub>D</sub>	2.0	w			
Maximum Fower Dissipation	$T_A = 25 ^{\circ}C$	. 0	1.3 <sup>b, c</sup>	VV			
	T <sub>A</sub> = 70 °C		0.8 <sup>b, c</sup>				
Operating Junction and Storage Temperature Rar	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C				
Soldering Recommendations (Peak Temperature)		260	C				

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Тур.	Max.	Unit			
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	$R_{thJA}$	77	95	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	33	40	J/ <b>VV</b>		

#### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. See Reliability Manual for profile. The DFN3X2 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 130 °C/W.
- g. Package limited.



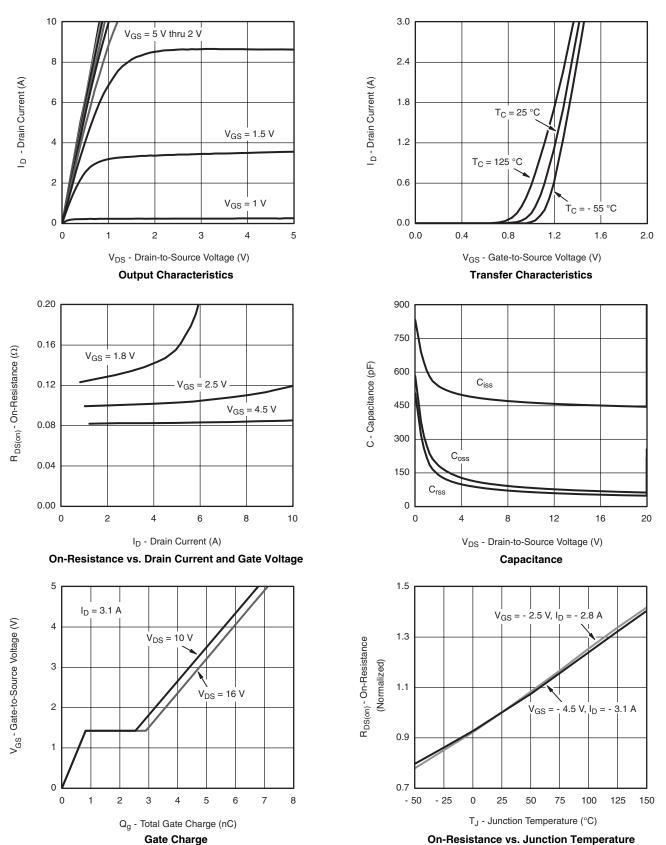
Parameter	Symbol	Test Conditions	Min.	Typ. <sup>a</sup>	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 20			٧	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 19		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		2.5			
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.4		- 1.0	V	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			- 100	nA	
		V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5		
On-State Drain Current <sup>b</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 10			Α	
	, ,	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 3.1 A		0.083		Ω	
Drain-Source On-State Resistance <sup>b</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 2.8 A		0.100			
		V <sub>GS</sub> = - 1.8 V, I <sub>D</sub> = - 2.5 A		0.130			
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 3.1 A		9.5		S	
Dynamic <sup>a</sup>							
Input Capacitance				455			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		70		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	20 4 40		54			
·	Qg	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 5 V, I <sub>D</sub> = - 3.1 A		7	11	1	
Total Gate Charge	9	20 1 00 1 2		6.2	9.3	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.1 \text{ A}$		0.85			
Gate-Drain Charge	Q <sub>gd</sub>			1.75			
Gate Resistance	R <sub>g</sub>	f = 1 MHz	1.22	6.1	12.2	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			3	6	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 4.2 $\Omega$		11	17		
Turn-Off Delay Time		$I_D\cong$ - 2.4 A, $V_{GEN}$ = - 8 V, $R_g$ = 1 $\Omega$		21	32		
Fall Time	t <sub>f</sub>			6	12		
Turn-On Delay Time	t <sub>d(on)</sub>			10	20		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 4.2 $\Omega$		32	48		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 2.4 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		25	38		
Fall Time	t <sub>f</sub>			6	12		
<b>Drain-Source Body Diode Characteristi</b>	cs				I.		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 2.6	Α	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 10		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 2.4 A, V <sub>GS</sub> = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			21	32	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 044 dl/dt 400 4/1- T 05 00		13	20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -2.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		17		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			4			

#### Notes:

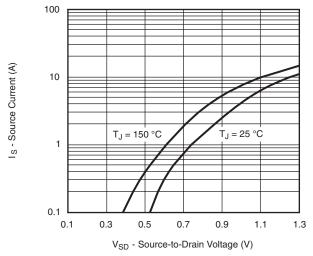
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

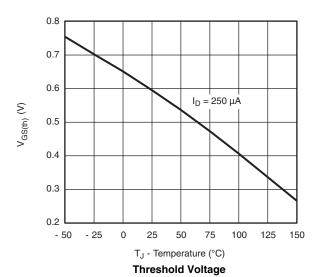








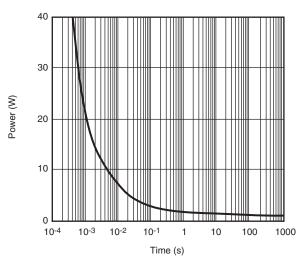
#### Source-Drain Diode Forward Voltage



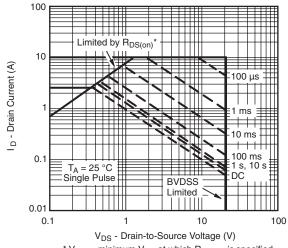
 $I_D = -3.1 \text{ A}$   $I_D = -3.1$ 

V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

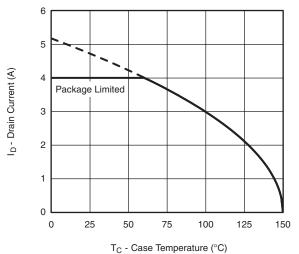


Single Pulse Power

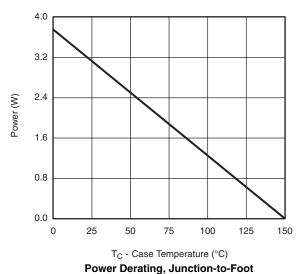


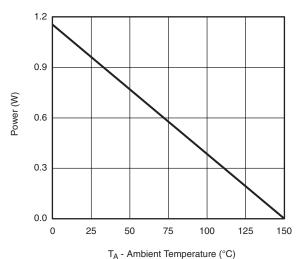
 $^{\star}$   $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified





### **Current Derating\***



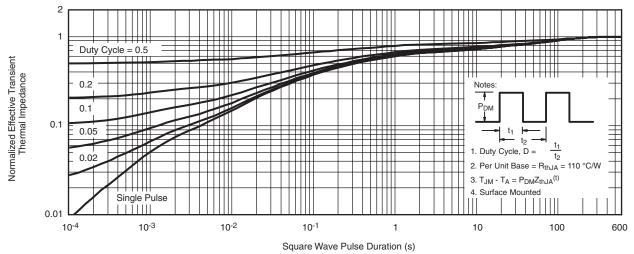


Power Derating, Junction-to-Ambient

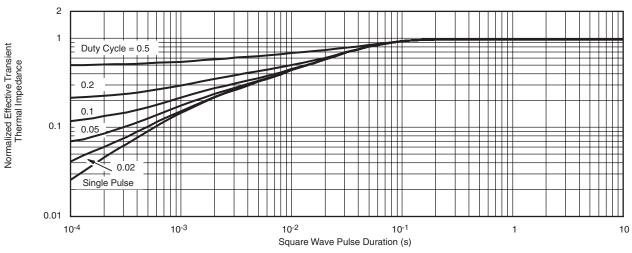
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





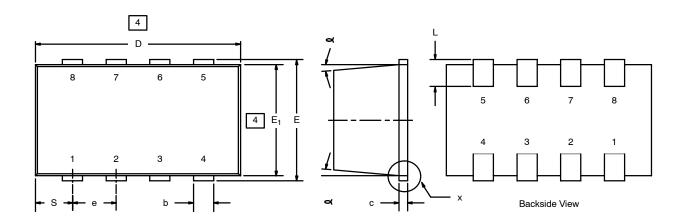
Normalized Thermal Transient Impedance, Junction-to-Ambient

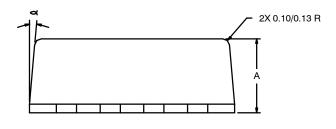


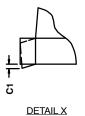
Normalized Thermal Transient Impedance, Junction-to-Foot



### DFN 3x2







### NOTES:

- 1. All dimensions are in millimeaters.
- 2. Mold gate burrs shall not exceed 0.13 mm per side.
- 3. Leadframe to molded body offset is horizontal and vertical shall not exceed 0.08 mm
- 4. Dimensions exclusive of mold gate burrs.
- 5. No mold flash allowed on the top and bottom lead surface.

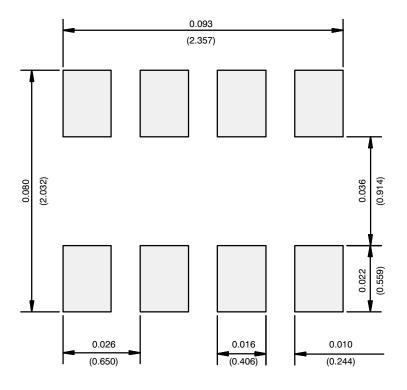
	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	1.00	-	1.10	0.039		0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.1	0.15	0.20	0.004	0.006	0.008	
с1	0	-	0.038	0	-	0.0015	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	1.825	1.90	1.975	0.072	0.075	0.078	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.0256 BSC			
L	0.28	-	0.42	0.011	-	0.017	
S	0.55 BSC			0.022 BSC			
7	5°Nom			5°Nom			
ECN: C-03528—Rev. F, 19-Jan-04 DWG: 5547							

服务热线:400-655-8788



### **RECOMMENDED MINIMUM PADS**

8



Recommended Minimum Pads Dimensions in Inches/(mm)



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